

TLE4998C8(D)

Programmable Linear Hall Sensor



Features

- Integration of two individual programmable Linear Hall sensor IC's with SPC (Short PWM Code) protocol with enhanced interface features based on SENT (Single Edge Nibble Transmission, defined by SAE J2716)
- 20-bit Digital Signal Processing (DSP)
- Digital temperature and stress compensation
- 16-bit overall resolution
- Operating automotive temperature range -40°C to 125°C
- Minimal drift of output signal over temperature and lifetime
- Programmable parameters stored in EEPROM with single-bit error correction:
 - SPC protocol modes: synchronous transmission, dynamic range selection, ID selection mode
 - Magnetic range, sensitivity (gain), offset, and polarity of the output slope
 - Bandwidth
 - Clamping levels
 - Customer temperature compensation coefficients for all common magnets
- Re-programmable until memory lock
- Supply voltage 4.5-5.5 V (4.1-16 V extended range)
- Configurable magnetic range: ±50 mT, ±100 mT, or ±200 mT
- Reverse-polarity and overvoltage protection for all pins
- Output short-circuit protection
- On-board diagnostics (overvoltage, EEPROM error)
- Output of internal magnetic field values and temperature
- Programming and operation of multiple sensors with common power supply
- Two-point calibration of magnetic transfer function without iteration steps
- Green Product (RoHS compliant)
- AEC Qualified

PRO-SIL[™] Features

• Safety Manual and Safety Analysis Summary Report





Potential applications

- Robust replacement of potentiometers: No mechanical abrasion, resistant to humidity, temperature, pollution and vibration
- Linear and angular position sensing in automotive and industrial applications with highest accuracy requirements
- Suited for safety applications such as pedal position, throttle position and steering torque sensing

Product validation

Qualified for automotive applications. Product validation according to AEC-Q100.

Description

The linear Hall IC TLE4998C8(D) has been designed specifically to meet the requirements of highly accurate angle and position detection.

The sensor provides a digital SPC (Short PWM Code) signal, based on the standardized SENT (Single Edge Nibble Transmission, SAE J2716) protocol. The SPC protocol allows transmissions initiated by the ECU. Two further operation modes are available.

- "range selection" for dynamically switching of the measurement range during operation
- "ID selection" to build a bus system with up to 4 IC's on a single output line and a common supply, which can be individually accessed by the ECU.

Each transmission sequence contains an adjustable number of nibbles representing the magnetic field, the temperature value and a status information of the sensor. The interface is further described in **Chapter 6**.

The output stage is an open-drain driver pulling the output pin to low only. Therefore, the high level needs to be obtained by an external pull-up resistor. This output type has the advantage that the receiver may use an even lower supply voltage (e.g. 3.3 V). In this case the pull-up resistor must be connected to the given receiver supply.

The IC is produced in BiCMOS technology with high voltage capability and it also has reverse-polarity protection.

Digital signal processing using a 16-bit DSP architecture together with digital temperature and stress compensation guarantees excellent stability over the whole temperature range and life time.

Product Name	Marking	Ordering Code	Package
TLE4998C8	C8S	SP002497758 ¹⁾	single sensor, PG-TDSO-8-1
TLE4998C8D	C8D	SP002497754 ¹⁾	dual sensor, PG-TDSO-8-2

Table 1Ordering Information

1) These ordering codes are valid for the B2 design onwards.



Table of Contents

1	Block Diagram	. 4
2	Pin Configuration	5
3 3.1 3.2	Functional Description	6
4	Application Circuit	. 7
5 5.1 5.2 5.3 5.3.1 5.3.2 5.3.2 5.3.3 5.3.4	General Product Characteristics Maximum Ratings Operating Range Electrical, Thermal and Magnetic Parameters Electrical Characteristics Magnetic Characteristics Electrical and Magnetic Characteristics in Undervoltage Range Magnetic Field Direction Definition	8 9 10 10 11 12
0.0.1		
6	SPC Output	14
6 6.1 6.2	SPC Output SPC Protocol Unit Time Setup	14 15
6 6.1 6.2 6.3 6.4	SPC Protocol Unit Time Setup Master Pulse SPC Modes	14 15 16 17
6 6.1 6.2 6.3	SPC Protocol Unit Time Setup Master Pulse	14 15 16 17 17
6 6.1 6.2 6.3 6.4 6.4.1 6.4.2	SPC Protocol Unit Time Setup Master Pulse SPC Modes Synchronous Transmission Synchronous Transmission Including Range Selection	14 15 16 17 17 17 18
6 6.1 6.2 6.3 6.4 6.4.1 6.4.2 6.4.3	SPC Protocol Unit Time Setup Master Pulse SPC Modes Synchronous Transmission Synchronous Transmission Including Range Selection Synchronous Mode with ID Selection	14 15 16 17 17 18 20 22 22
 6 6.1 6.2 6.3 6.4 6.4.1 6.4.2 6.4.3 7 8 8.1 	SPC Protocol Unit Time Setup Master Pulse SPC Modes Synchronous Transmission Synchronous Transmission Including Range Selection Synchronous Mode with ID Selection Synchronous Mode with ID Selection Configuration and Calibration Parameters Error Detection Voltages Outside the Operating Range	14 15 16 17 17 17 18 20 22 22 22



Block Diagram

1 Block Diagram



Figure 1 Block Diagram



Pin Configuration

2 Pin Configuration

Figure 2 shows the location of the Hall elements in the package and the pin configuration of the TLE4998C8(D).



Figure 2 Pin Configuration of PG-TDSO-8 package

Table 2	TLE4998C8(D) Pin Definitions and Functions
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Pin No.	Symbol	TLE4998C8 Function	TLE4998C8D Function	
1	TST	Test pin (connection to GND is recommended)	Test pin (top die, connection to GND is recommended)	
2	VDD	Supply voltage / programming interface	Supply voltage / programming interface (top die)	
3	GND	Ground	Ground (top die)	
4	OUT	Output / programming interface	Output / programming interface (top die	
5	OUT	Not connected	Output / programming interface (bottom die)	
6	GND	Not connected	Ground (bottom die)	
7	VDD	Not connected	Supply voltage / programming interface (bottom die)	
8	TST	Not connected	Test pin (bottom die, connection to GND is recommended)	



Functional Description

3 Functional Description

3.1 Principle of Operation

- A magnetic flux is measured by a Hall-effect cell
- The output signal from the Hall-effect cell is converted from analog to digital signals
- The chopped Hall-effect cell and continuous-time A/D conversion ensure a very low and stable magnetic offset
- A programmable low-pass filter to reduce noise
- The temperature is measured and A/D converted
- Temperature compensation is done digitally using a second-order function
- Digital processing of the output value is based on zero field and sensitivity value
- The output value range can be clamped by digital limiters
- The final output value is represented by the data nibbles of the SPC protocol

3.2 Transfer Functions

The examples in **Figure 3** show how different magnetic field ranges can be mapped to the desired output value ranges.

- Polarity Mode:
 - **Bipolar**: Magnetic fields can be measured in both orientations. The limit points do not necessarily have to be symmetrical around the zero field point
 - **Unipolar**: Only north- or south-oriented magnetic fields are measured
- Inversion: Both gain can be set to positive values, negative values or positive/negative values.



Figure 3 Examples of Operation



Application Circuit

4 Application Circuit

Figure 4 shows the connection of two Linear Hall sensors to a microcontroller.



Figure 4 Application Circuit

The application circuit shown should be regarded as an example only.



General Product Characteristics

5 General Product Characteristics

5.1 Maximum Ratings

All further given specifications are regarded to each of the implemented sensors IC's, or otherwise noted.

Table 3Absolute Maximum Ratings

Parameter	Symbol	ymbol Values			Unit	Note or	
		Min.	Тур.	Max.	_	Test Condition	
Junction temperature	TJ	- 40	-	160 ¹⁾	°C	-	
Voltage on V _{DD} pin with respect to ground	V _{DD}	-18	-	18.35	V	2)3)	
Supply current @ overvoltage V _{DD} max.	I _{DDov}	-	-	15	mA	-	
Reverse supply current @ V _{DD} min.	I _{DDrev}	-1	-	0	mA	-	
Voltage on output pin with respect to ground	V _{OUT}	-14)	-	18.35 ⁵⁾	V	-	
Magnetic field	B _{MAX}	-	-	1	Т	-	
ESD protection	V _{ESD}	-	-	±2	kV	According HBM ANSI/ESDA/JEDEC JS-001	

1) For limited time of 96 h. Depends on customer temperature lifetime cycles. Please ask Infineon for support.

2) Higher voltage stress than absolute maximum rating, e.g. 150% in latch-up tests is not applicable. In such cases, $R_{series} \ge 100 \Omega$ for current limitation is required.

3) Max 1h, in operating temperature range.

4) IDD can exceed 10 mA when the voltage on OUT is pulled below -1 V (-5 V at room temperature).

5) VDD = 5 V, open drain permanent low, for max. 10 minutes

Attention: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Furthermore, only single error cases are assumed. More than one stress/error case may also damage the device.

> Exposure to absolute maximum rating conditions for extended periods may affect device reliability. During absolute maximum rating overload conditions the voltage on VDD pins with respect to ground (VSS) must not exceed the values defined by the absolute maximum ratings. Lifetime statements are an anticipation based on an extrapolation of Infineon's qualification test results. The actual lifetime of a component depends on its form of application and type of use etc. and may deviate from such statement. The lifetime statement shall in no event extend the agreed warranty period.



General Product Characteristics

5.2 Operating Range

The following operating conditions must not be exceeded in order to ensure correct operation of the TLE4998C8(D). All parameters specified in the following sections refer to these operating conditions and each of the implemented sensors IC's if applicable or unless otherwise indicated.

Table 4Operating Range

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Тур.	Max.		
Supply voltage	V _{DD}	4.5	-	5.5	V	-
		4.1	-	16 ¹⁾²⁾	V	Extended range
Supply undervoltage	V _{DDuv}	V _{DDpon} ³⁾	-	4.1	V	Undervoltage range, reduced magnetic performance (see Table 7)
Output pull-up voltage ⁴⁾	V _{pull-up}	_	-	18.35	V	-
Load resistance ⁴⁾	R _L	1	-	_	kΩ	-
Output current ⁴⁾	l _{out}	0	-	5	mA	-
Output leakage current ⁵⁾	I _{out, leak}	40	85	140	μΑ	V _{pull-up} = 5V and 0< V _{DD} <v<sub>DDuv</v<sub>
Load capacitance ⁴⁾	CL	1	_	8	nF	-
Ambient temperature ⁶⁾	T _A	-40	-	125	°C	max. 1200 h at 125°C ⁷⁾

1) For supply voltages > 12 V, a series resistance $R_{series} \ge 100 \Omega$ is recommended

2) The open drain switch off, due to overvoltage on the V_{DD} line, can take place in the range of 16.65 V to 18.35 V, as defined in **Chapter 8.1** of the data sheet.

3) V_{DDpon} ... power-on reset level, see **Table 5**

4) Output protocol characteristics depend on these parameters, R_L must be according to max. output current.

5) Internal leakage from Out pin to GND pin in case V_{DD} is lost.

6) $R_{THja} \leq 150 \text{ K/W}.$

7) Maximum exposure time at other ambient temperatures between -40°C and 125°C shall be calculated based on the values specified in this table using the Arrhenius model.

Note: Keeping signal levels within the limits specified in this table ensures operation without overload conditions.



General Product Characteristics

5.3 Electrical, Thermal and Magnetic Parameters

All specification values are valid over temperature and lifetime, unless noted otherwise.

5.3.1 Electrical Characteristics

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Тур.	Max.		
Supply current	I _{DD}	3	6	8	mA	per die
Thermal resistance ¹⁾	R _{thJA}	-	-	150	K/W	junction to air
Power-on time ²⁾	t _{Pon}	-	0.7	2	ms	≤ ±5% target out value
		-	15	20		≤ ±1% target out value
Power-on reset level ³⁾	V _{DDpon}	3.1	3.5	3.9	V	
Output impedance	Z _{OUT}	20	40	70	kΩ	
Output fall time	t _{fall}	2	3.5	5	μs	V _{OUT} 4.5 V to 0.5 V ⁴⁾
Output rise time	t _{rise}	-	20	_	μs	V _{OUT} 0.5 V to 4.5 V ⁴⁾
Output low saturation	V _{OUTsat}	-	0.3	0.6	V	I _{OUTsink} = 5 mA
voltage		-	0.2	0.4	V	I _{OUTsink} = 2.2 mA
Output noise (rms)	OUT _{noise}	-	-	2	LSB ₁₂	With LP filter setting from 80 Hz until 1390 Hz ⁵⁾
Oscillator frequency variation	∆f / f	-20	-	20	%	Nominal oscillator frequency: 8MHz

Table 5Electrical Characteristics

1) Values derived from a simulation with a 4-layer PCB

2) Response time to set up output data at power on when a constant field is applied. The first value given has a ±5% error, the second value has a ±1% error.

3) Power-on and power-off

4) Depends on External R_L and C_L , See **Application Circuit**

5) Range ±50 mT (also valid for ranges ±100 mT and ±200 mT), Gain 1.0 (scales linearly with gain)



Figure 5 Output Characteristic



General Product Characteristics

Calculation of the Junction Temperature

The internal power dissipation P_{TOT} of the sensor increases the chip junction temperature above the ambient temperature.

The power multiplied by the total thermal resistance R_{thJA} (Junction to Ambient) added to T_A leads to the final junction temperature. R_{thJA} is the sum of the addition of the two components, Junction to Case and Case to Ambient.

 $R_{thJA} = R_{thJC} + R_{thCA}$ $T_{J} = T_{A} + \Delta T = R_{thJA} \times P_{TOT} = R_{thJA} \times (V_{DD} \times I_{DD} + V_{OUT} \times I_{OUT}); I_{DD}, I_{OUT} > 0, \text{ if direction is into IC}$

Example (assuming no load on V_{OUT} and TLE4998C8(D) type):

- V_{DD} = 5 V
- I_{DD} = 8 mA
- ΔT= 150 [K/W] x (5 [V] x 0.008 [A] + 0 [VA]) = 6 K per silicon

For molded sensors, the calculation with R_{thJC} is more adequate.

5.3.2 Magnetic Characteristics

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Тур.	Max.		
Sensitivity	S ¹⁾	±8.2	-	±245	LSB ₁₂ /mT	programmable ²⁾
Sensitivity drift	ΔS	-2.0	_	+2.0	%	
Magnetic field range	MFR	±50	±100	±200	mT	programmable ³⁾
Integral nonlinearity	INL	_	±2.0	±4.1	LSB ₁₂	4)
Magnetic offset	B _{os}	-	±100	±400	μΤ	
Magnetic offset drift	ΔB _{os}	-	±1	±5	μT/°C	
Magnetic hysteresis	B _{HYS}	-	-	20	μΤ	in 50mT range
				10		in 100mT range

Table 6Magnetic Characteristics

1) Defined as $\Delta OUT / \Delta B$.

2) Programmable in steps of 0.024%.

3) Depending on offset and gain settings, the output may already be saturated at lower fields.

4) Range ±50 mT (also valid for ranges ±100 mT and ±200 mT), Gain = 1.0 (scales linearly with gain)



General Product Characteristics

5.3.3 Electrical and Magnetic Characteristics in Undervoltage Range

Parameter	Symbol	Values			Unit	Note or Test Condition	
		Min.	Тур.	Max.			
Sensitivity drift	S _{E(T)}	-	-	+2.5/-7.5	%		
Magnetic offset drift	ΔB _{OS}	-	-	±400	μΤ		
Integral nonlinearity	INL	-	-	±8.2	LSB ₁₂	1)	
Output noise (rms)	OUT _{noise}	-	-	8	LSB ₁₂	With LP filter setting from 80 Hz until 1390 Hz ¹⁾	

Table 7 Electrical and Magnetic Characteristics in Supply Undervoltage Range

1) Range $\pm 50 \text{ mT}$ (also valid for ranges $\pm 100 \text{ mT}$ and $\pm 200 \text{ mT}$), Gain = 1.0 (scales linearly with gain)

5.3.4 Magnetic Field Direction Definition

Figure 6 shows the definition of the magnetic field direction. By standard the south pole field defines the positive field values of the top die of the TLE4998C8(D).



Figure 6 Definition of magnetic field direction of the TLE4998C8(D).

For the TLE4998C8D, the bottom die measures the inverted field value of the top die. This leads to a default output characteristic as shown in **Figure 7**.



General Product Characteristics



Figure 7 Example of the dual die output characteristic (range 50 mT, gain 1.0, typical)



6 SPC Output

The sensor supports a SPC (Short PWM Code) protocol, which enhances the standard SENT protocol (Single Edge Nibble Transmission) defined by SAE J2716. SPC is a synchronous SENT output, triggered by a master pulse from the ECU.

6.1 SPC Protocol

The single edge is defined by a 3 unit time (UT) low pulse on the output, followed by the high time defined in the protocol (nominal values, may vary by tolerance of internal RC oscillator and the programming, see **Chapter 6.2**). All values are multiples of a configurable unit time. A transfer consists of the following parts:

- A trigger pulse by the master, which initiates the data transmission
- A synchronization period of 56 UT (in parallel, a new sample is calculated)
- A status nibble of 12-27 UT
- Between 3 and 6 data nibbles of 12-27 UT each (number is programmable, see **Table 8**), representing the Hall value and temperature information
- A Checksum (CRC) nibble of 12-27 UT.
- An end pulse to terminate the SPC transmission.



Figure 8 SPC Frame

The CRC checksum includes the status nibble and the data nibbles and can be used to check the validity of the decoded data. It is calculated using a polynomial $x^4 + x^3 + x^2 + 1$ with a seed value of 0101. The calculation scheme of the CRC is described in detail in the **TLE4998 User's Manual**.

The sensor is available for the next sample 90 µs after the falling edge of the end pulse. The sensor's sampling time is at the beginning of the synchronization period.

The number of transmitted SPC nibbles is programmable to customize the amount of information sent by the sensor. The default frame contains a 16 bit Hall value and an 8bit temperature value.

Table 8 Frame Selection

Frame Type	Parameter F	Data Nibbles
16 bit Hall, 8 bit temperature	0	6 nibbles
16 bit Hall	1	4 nibbles
12 bit Hall, 8 bit temperature	2	5 nibbles
12 bit Hall	3	3 nibbles



The temperature is coded as an 8 bit value. The value is transferred in unsigned integer format and corresponds to the range between -55 °C and +200 °C, so a transferred value of 55 corresponds to 0 °C. The temperature is additional information and although it is not calibrated, may be used for a plausibility check, for example. **Table 9** shows the mapping between junction temperature and the transmitted value in the SPC frame.

Table 9 Mapping of Temperature Value

Junction Temperature	Typ. Decimal Value from Sensor	Note
- 55 °C	0	Theoretical lower limit ¹⁾
0 °C	55	-
25 °C	80	-
200 °C	255	Theoretical upper limit ¹⁾

1) Theoretical range of temperature values, not operating temperature range.

The status nibble allows to check internal states and conditions of the sensor.

- Depending on the selected SPC mode, the first two bits of the status nibble contain either the selected magnetic range or the ID of the sensor and allow therefore an easy interpretation of the received data.
- The third bit is set to 1 for the first transmission after the sensor returns from an overvoltage operation with disabled open drain stage to regular operation (see **Chapter 8**).
- The fourth bit is switched to 1 for the first data package transferred after a reset.

6.2 Unit Time Setup

The basic SPC protocol unit time granularity is defined as 3 µs. Every timing is a multiple of this basic time unit. To achieve more flexibility, trimming of the unit time can be used to:

- Allow a calibration trim within a timing error of less than 20% clock error (as given in SAE standard)
- Allow a modification of the unit time for small speed adjustments

This enables a setup of different unit times. The output characteristic depends on the external load, the wiring, as well on the pull-up resistor and the temperature. Furthermore, sufficient driving capability of the reciever is required, in order to fulfill the master pulse requirements.

Table 10Pre-divider Setting

Parameter	Symbol	Values		Values Unit Note or T		Note or Test Condition
		Min.	Тур.	Max.	-	
Unit time	t _{unit}	2.0	-	3.88	μs	ClkUNIT=8 MHz ¹⁾²⁾

1) Default setting is 3 μs nominal SPC unit time.

2) Subject to RC oscillator frequency variation ± 20%.

The nominal unit time is calculated by:

 $t_{\text{UNIT}} = (Prediv + 16) / Clk_{\text{UNIT}}$

$$Clk_{\text{UNIT}} = 8\text{MHz} \pm 20\%$$

(6.1)



6.3 Master Pulse

An SPC transmission is initiated by a Master pulse from the ECU on the OUT pin. To detect a low-level on the OUT pin, the voltage has to be below a threshold V_{thf} . The sensor detects that the OUT line has been released as soon as V_{thr} is crossed. **Figure 9** shows the timing definitions for the master pulse. The master low time t_{mlow} as well as the total trigger time t_{mtr} are individual for the different SPC modes and are given in the subsequent sections.

It is recommended to choose the typical master low time exactly between the minimum and the maximum possible time: $t_{mlow,typ} = (t_{mlow,min} + t_{mlow,max}) / 2$. The master shall provide a high timing accuracy (approx. 1%). If the master low time exceeds the maximum low time, the sensor does not respond and is available for a next triggering 30µs after the master pulse crosses V_{thr} . $t_{md,tot}$ is the delay between internal triggering of the falling edge in the sensor and the triggering of the ECU.

Note: Internal acceptance limits for trigger low time are wider than those specified in **Table 13**, **Table 14**, and **Table 15**, to accomodate +-20% oscillator drift.

Parameter	Symbol		Values			Note or Test Condition
		Min.	Тур.	Max.		
Falling edge threshold	V _{thf}	1.1	1.3	1.7	V	-
Rising edge threshold	V _{thr}	1.25	1.43	1.8	V	-
Total trigger time	t _{mtr}	_	13	_	UT	Synchronous mode ¹⁾²⁾
		—	56	—	UT	Dyn. range mode ¹⁾²⁾
		_	90	_	UT	ID selection mode ¹⁾²⁾
Master delay time	t _{md.tot}	3.7	5.8	7.9	μs	3)

Table 11 Master Pulse Parameters

1) UT = Programmed nominal SPC unit time

2) Trigger time in the sensor is fixed to the number of unit times specified in the "typ." column, but the effective trigger time varies due to the sensor's clock variation

3) Depends on External R_L , C_L and V_{dd}



Figure 9 SPC Master Pulse Timing



SPC Output

6.4 SPC Modes

SPC enables the use of enhanced protocol functionality due to the ability to select between "synchronous", "range selection" and "ID selection" protocol mode. The ID register is only used in ID selection mode.

Table 12SPC Mode Selection

Mode	Parameter Prot MSB	Parameter Prot LSB		
Synchronous	0	No effect		
Dynamic range selection	1	0		
ID selection	1	1		

6.4.1 Synchronous Transmission

In the "synchronous" mode, the sensor (slave) starts to transfer a complete data frame only after a low pulse is forced by the master on the OUT pin. This means that the data line is bidirectional - an open drain output of the micro controller (master) sends the trigger pulse. The sensor then initiates a sync pulse and starts to calculate the new output data value. After the synchronization period, the data follows in form of a standard SENT frame, starting with the status, data and CRC nibbles. At the end, an end pulse allows the CRC nibble decoding and indicates that the data line is idle again. The timing diagram in **Figure 8** visualizes a synchronous transmission.

Table 13Master Pulse Timing for Synchronous Mode

Parameter	Symbol	Values		Unit	Note or Test Condition	
		Min.	Тур.	Max.		
Master low time	t _{mlow}	1.5	2.75	4	UT ¹⁾	-

1) UT = Programmed nominal SPC unit time.



Figure 10 Bidirectional Communication in Synchronous Mode

6.4.2 Synchronous Transmission Including Range Selection

The low time duration of the master can be used to select the magnetic range of the sensor in SPC dynamic range selection mode.

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Тур.	Max.		
Master low time	t _{mlow}	1.5	3.25	5	UT ¹⁾	Range = 200 mT (<i>R</i> =0)
		9	12	15	UT	Range = 100 mT (<i>R</i> =1)
		24	31.5	39	UT	Range = 50 mT (<i>R</i> =3)



1) UT = Programmed nominal SPC unit time.

Changing the range takes some time due to the settling time of internal circuitry. The first sample after a range switch therefore still displays a value sampled with the old range setting and the second transmission after changing the range displays the new range with reduced accuracy.

6.4.3 Synchronous Mode with ID Selection

In ID selection mode, one of up to four sensors are selectable on a bus (bus mode, 1 master with up to 4 slaves). This allows parallel connection of up to 4 sensors on one data line, as illustrated in **Figure 11**.



Figure 11 Bidirectional Communication with ID Selection

In this mode, the sensor starts to transfer complete packages only after receiving a master low pulse with an ID that is equivalent to the programmed value in its ID register. The mapping between master low time and ID is given in **Table 15**. A proper addressing requires the different sensors on a same bus to be programmed with the same nominal SPC unit time.

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Тур.	Max.		
Master low time	t _{mlow}	9	10.5	12	$UT^{1)}$	ID = 0
		19	21	23	UT	ID = 1
		35.5	38	40.5	UT	ID = 2
		61.5	64.5	67.5	UT	ID = 3

Table 15 Master Pulse Timing for ID Selection Mode

1) UT = Programmed nominal SPC unit time.



SPC Output



19



Configuration and Calibration Parameters

7 Configuration and Calibration Parameters

The TLE4998C8(D) has several configurable parameters which are stored in the EEPROM. These parameters affect the internal data processing and compensation and the output protocol. This chapter gives an overview of the parameters. A detailed description of all the parameters and the programming procedure is given in the **TLE4998 User's Manual**.

Parameter	Setting range	Note
Magnetic range	±50 mT ±100 mT ±200 mT	Magnetic input range of Hall ADC
Gain	-4.04.0	Gain value of +1.0 corresponds to typical 32 LSB ₁₂ /mT sensitivity in 100 mT range (64 LSB ₁₂ /mT in 50mT range)
Offset	-16384 $LSB_{12} \dots 16384 LSB_{12}$	Quantization step: 1 LSB ₁₂
Clamping low level	0 LSB ₁₆ 64512 LSB ₁₆	Quantization step: 1024 LSB ₁₆ (see Figure 13)
Clamping high level	1023 LSB ₁₆ 65535 LSB ₁₆	Quantization step: 1024 LSB ₁₆
Bandwidth ¹⁾	80 Hz 240 Hz 440 Hz 640 Hz 860 Hz 1100 Hz 1390 Hz Off	Low-pass filter cut-off (-3 dB) frequency (see Figure 14)
1 st order temperature coefficient TC ₁	-1000 ppm/°C 2500 ppm/°C	2)
2 nd order temperature coefficient TC ₂	-4 ppm/°C ² 4 ppm/°C ²	3)
SPC unit time ¹⁾	2.0 μs 3.88 μs	see Chapter 6.2
SPC protocol frames	16 bit Hall + 8 bit temperature 16 bit Hall 12 bit Hall + 8 bit temperature 12 bit Hall	see Table 8
SPC mode	Synchronous Dynamic Range ID Selection	see Chapter 6.4

Table 16 TLE4998C8(D) Paramters

1) Subject to oscillator variation ±20%.

2) Relative range to Infineon temperature pre-calibration, the maximum adjustable range is limited by the register-size and depends on specific pre-calibrated TL setting, full adjustable range: -2441 to +5355 ppm/°C.

3) Relative range to Infineon temperature pre-calibration, the maximum adjustable range is limited by the register-size and depends on specific pre-calibrated TQ setting, full adjustable range: -15 to +15 ppm/°C².



Configuration and Calibration Parameters







Figure 14 DSP Input Filter (Magnitude Plot)



Error Detection

8 Error Detection

Different error cases can be detected by the On-Board Diagnostics (OBD) and reported to the micro controller in the status nibble (see **SPC Output**).

8.1 Voltages Outside the Operating Range

- Inside the ratings specified in Table 3 "Absolute Maximum Ratings" on Page 8
- Outside the range specified in Table 4 "Operating Range" on Page 9

The output signals an error condition if V_{DD} crosses the overvoltage threshold level.

Table 17 Overvoltage

Parameter	Symbol	Values			Unit	Note or
		Min.	Тур.	Max.		Test Condition
Overvoltage threshold	V _{DDov}	16.65	17.5	18.35	V	

8.2 EEPROM Error Correction

The parity method is able to correct a single bit in the EEPROM line. One other single bit error in another EEPROM line can also be detected, but not corrected. In case there is an incorrectable EEPROM failure, the open drain stage is disabled and permanently kept in off state (high ohmic/sensor defect).



Package Outlines

9 Package Outlines

PG-TDSO-8 Package Outlines



Figure 15 PG-TDSO-8 (PG-TDSO-<u>P</u>lastic <u>Green Thin Dual Small Outline</u>), Package Dimensions

Distance Chip to package

Figure 16 shows the distance of the chip surface to the PG-TDSO-8 surface.



Figure 16 Distance of chip surface to package surface

Moisture Sensitivity Level (MSL)

The PG-TDSO-8 fulfills the MSL level 3 according to IPC/JEDEC J-STD-033B.1.



Package Outlines

PG-TDSO-8 Package Marking



Figure 17 PG-TDSO-8 (PG-TDSO-<u>P</u>lastic <u>Green Thin D</u>ual <u>S</u>mall <u>O</u>utline), Package Marking

Package Outlines



Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

For further information on alternative packages, please visit our website: http://www.infineon.com/packages.



Revision History

10 Revision History

Revision History						
Page or Item	Subjects (major changes since previous revision)					
Rev. 2.0, 2018-	05					
Updated Datas	heet to new Infineon template					
Page 2	Removed AEC Q100 Revision version.					
Page 2	Updated Ordering Code for the TLE4998C8 for the B2 parts.					
Page 2	Updated Ordering Code for the TLE4998C8D for the B2 parts.					
Page 2	Added footnote to Ordering Code.					
Page 9	Added new parameter Output leakage current to Operating Range .					
Page 10	Updated Footnote Hyperlink Depends on External R_L and C_L, See Application Circuit .					

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Document reference

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